

Description

PECJ P-channel Enhancement Mode Power MOSFET

Features

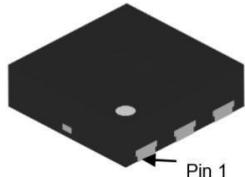
- -12V, -16A
- $R_{DS(ON)} < 18m\Omega$ @ $V_{GS} = -4.5V$
- $R_{DS(ON)} < 24m\Omega$ @ $V_{GS} = -2.5V$
- Advanced Trench Technology
- Provide Excellent $R_{DS(ON)}$ and Low Gate Charge
- Lead free product is acquired

Application

- Load Switch
- PWM Application
- Power management

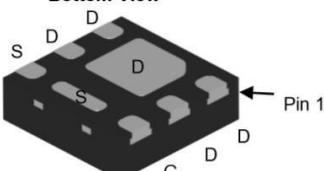


Top View

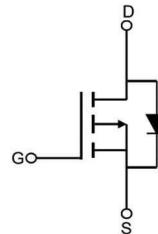
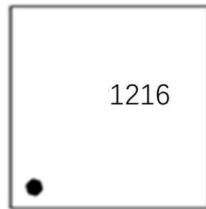


DFN2X2-6L

Bottom View



Marking and pin Assignment



Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	OUTLINE	Device Package	Reel Size	Reel (PCS)	Per Carton (PCS)
1216	PECJ1216A	TAPING	DFN2X2-6L	7inch	4000	160000

Absolute Maximum Ratings ($T_c=25^\circ C$ unless otherwise specified)

Symbol	Parameter		Max.	Units
V_{DSS}	Drain-Source Voltage		-12	V
V_{GSS}	Gate-Source Voltage		± 12	V
I_D	Continuous Drain Current	$T_c = 25^\circ C$	-16	A
		$T_c = 100^\circ C$	-10	A
I_{DM}	Pulsed Drain Current ^{note1}		-64	A
P_D	Power Dissipation	$T_c = 25^\circ C$	8	W
R_{eJC}	Thermal Resistance, Junction to Case		15.6	$^\circ C/W$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ C$

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristics						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}$, $I_D = -250\mu\text{A}$	-12	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -12\text{V}$, $V_{GS}=0\text{V}$,	-	-	-1	μA
I_{GSS}	Gate to Body Leakage Current	$V_{DS}=0\text{V}$, $V_{GS} = \pm 12\text{V}$	-	-	± 100	nA
On Characteristics						
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_D = -250\mu\text{A}$	-0.4	-0.7	-1.0	V
$R_{DS(\text{on})}$ note2	Static Drain-Source on-Resistance	$V_{GS} = -4.5\text{V}$, $I_D = -8\text{A}$	-	14	18	$\text{m}\Omega$
		$V_{GS} = -2.5\text{V}$, $I_D = -5\text{A}$	-	18	24	
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS} = -6\text{V}$, $V_{GS}=0\text{V}$, $f=1.0\text{MHz}$	-	2700	-	pF
C_{oss}	Output Capacitance		-	680	-	pF
C_{rss}	Reverse Transfer Capacitance		-	590	-	pF
Q_g	Total Gate Charge	$V_{DS} = -6\text{V}$, $I_D = -8\text{A}$, $V_{GS} = -4.5\text{V}$	-	35	-	nC
Q_{gs}	Gate-Source Charge		-	5	-	nC
Q_{gd}	Gate-Drain("Miller") Charge		-	10	-	nC
Switching Characteristics						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD} = -6\text{V}$, $I_D = -8\text{A}$, $V_{GS} = -4.5\text{V}$, $R_{\text{GEN}}=2.5\Omega$	-	11	-	ns
t_r	Turn-on Rise Time		-	35	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	30	-	ns
t_f	Turn-off Fall Time		-	10	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I_s	Maximum Continuous Drain to Source Diode Forward Current	-	-	-16	-	A
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current	-	-	-64	-	A
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS}=0\text{V}$, $I_s = -16\text{A}$	-	-0.8	-1.2	V

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Typical Performance Characteristics

Figure 1: Output Characteristics

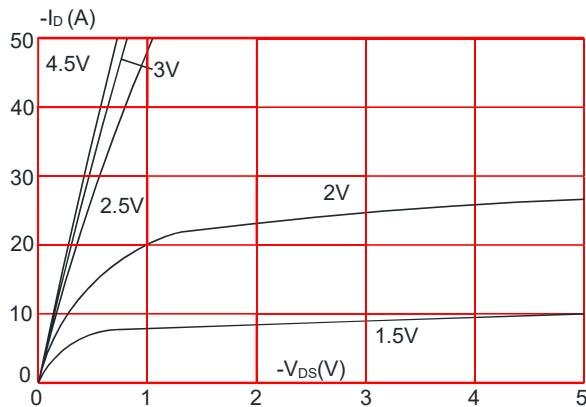


Figure 3: On-resistance vs. Drain Current

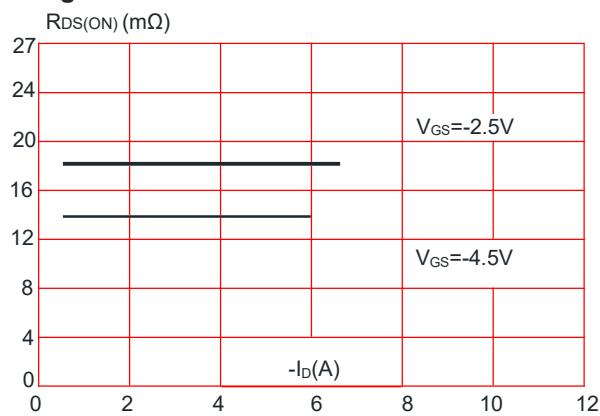


Figure 5: Gate Charge Characteristics

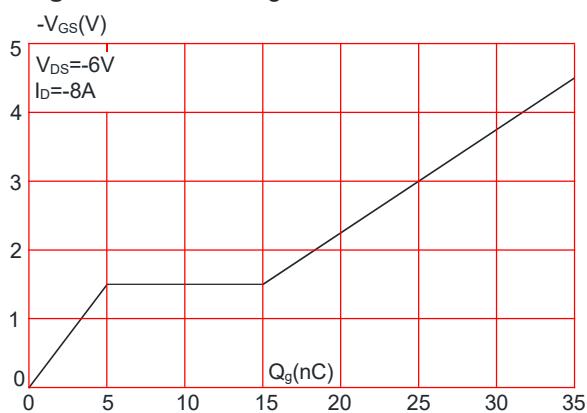


Figure 2: Typical Transfer Characteristics

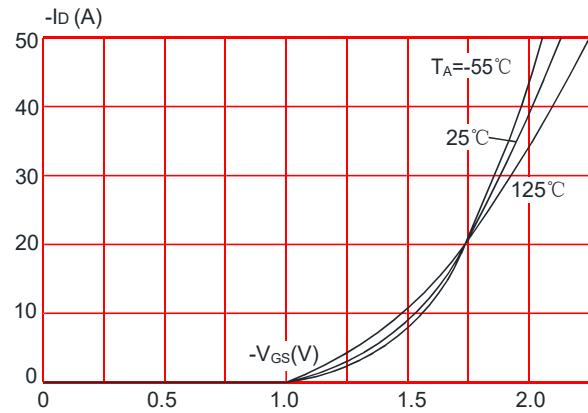


Figure 4: Body Diode Characteristics

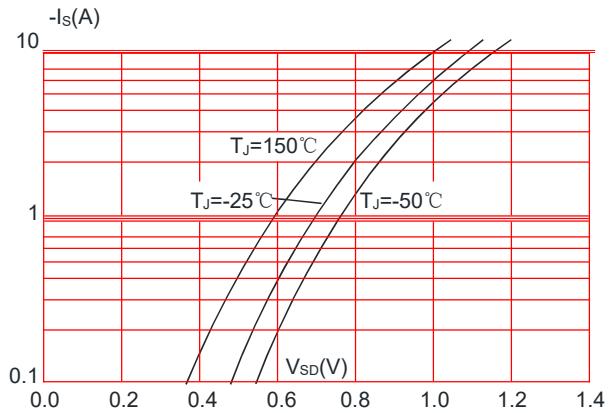


Figure 6: Capacitance Characteristics

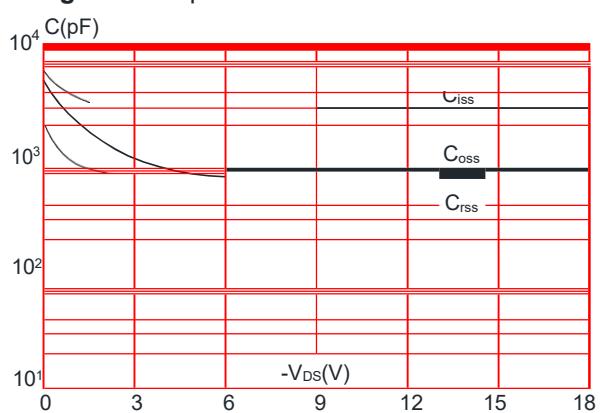


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

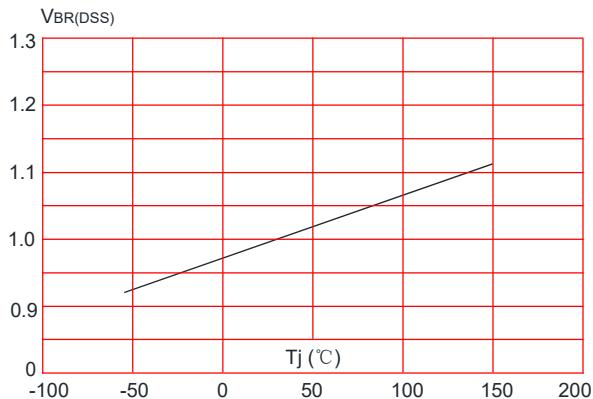


Figure 9: Maximum Safe Operating Area

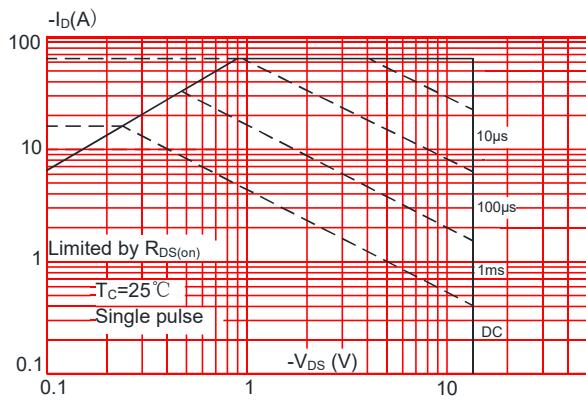


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

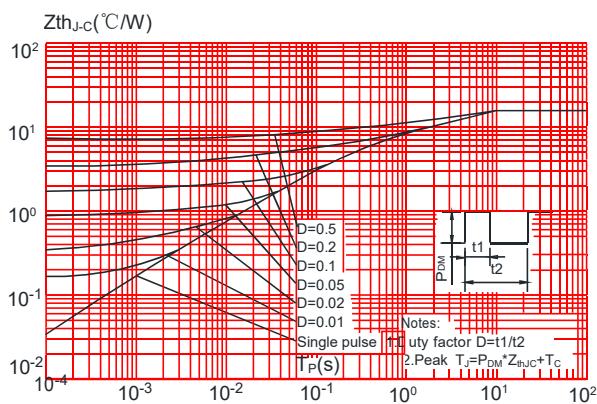


Figure 8: Normalized on Resistance vs. Junction Temperature

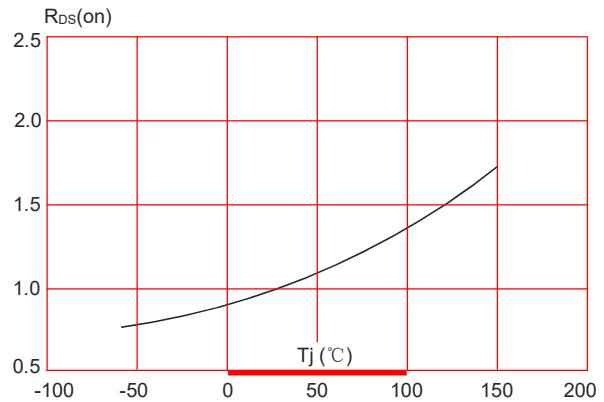
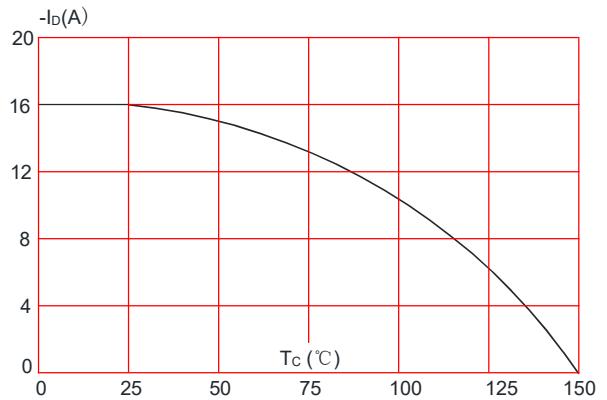
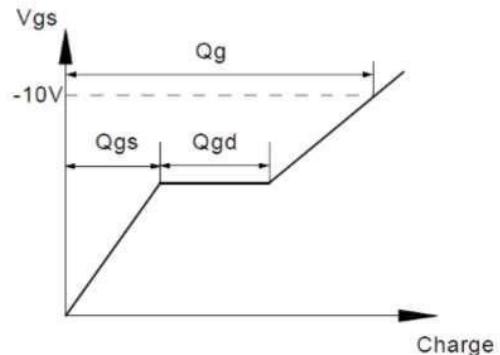
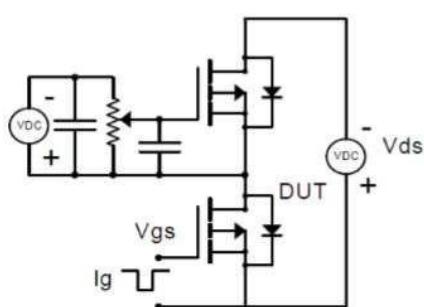


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

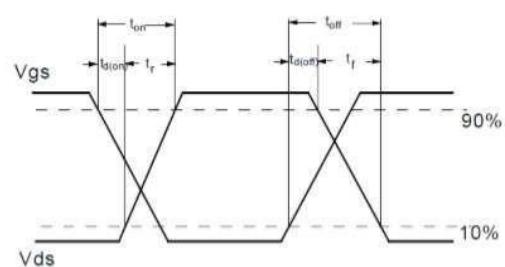
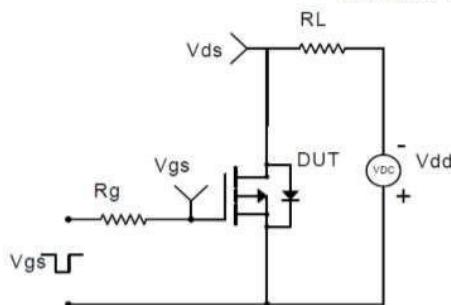


Test Circuit

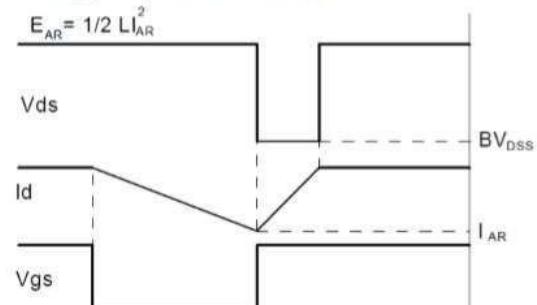
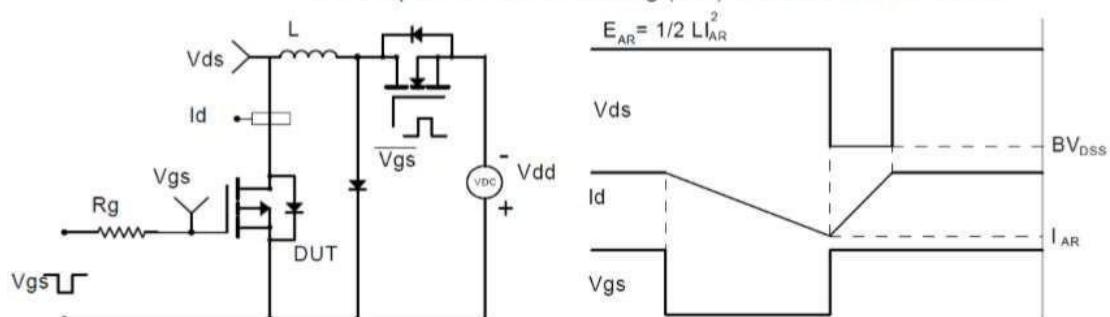
Gate Charge Test Circuit & Waveform



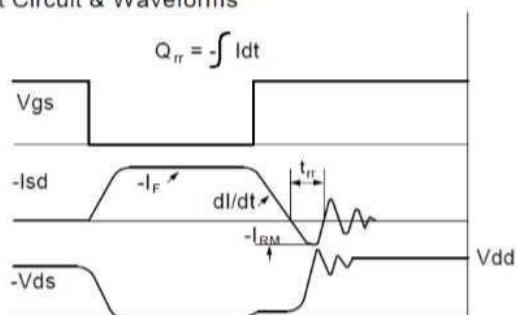
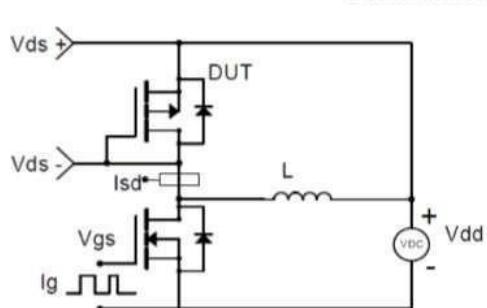
Resistive Switching Test Circuit & Waveforms



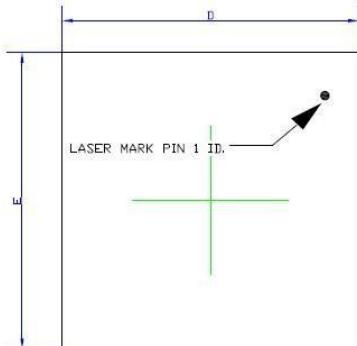
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



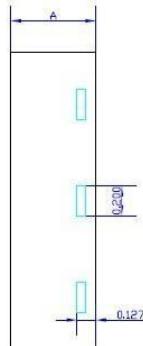
Diode Recovery Test Circuit & Waveforms



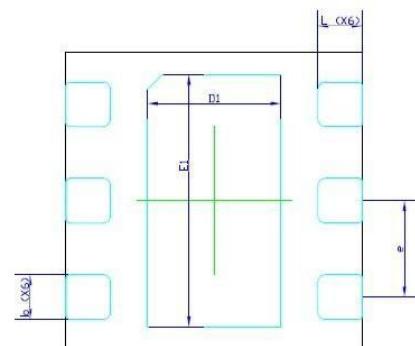
Package Mechanical Data- DFN2X2-6L



TOP VIEW



SIDE VIEW



BOTTOM VIEW

COMMON DIMENSION (MM)			
PKG	DFN2020-6L		
SYMBOL	MIN.	NOM.	MAX
A	0.527	0.552	0.577
b	0.20	0.25	0.30
D	1.90	2.00	2.10
E	1.90	2.00	2.10
D1	0.80	0.90	1.00
E1	1.60	1.70	1.80
e	0.65 REF.		
L	0.25	0.30	0.35